



# SGM44600

## 4Ω, High Speed, Low Voltage Dual, DPDT Analog Switch

### GENERAL DESCRIPTION

The SGM44600 is a dual, high-speed, low-voltage, double-pole/double-throw (DPDT) CMOS analog switch that is designed to operate from a single 1.8V to 5.5V power supply. It features high-bandwidth (300MHz) and low on-resistance (4Ω TYP), targeted applications for audio switching.

The SGM44600 consists of four SPDT switches. The configuration can be used as a bidirectional quad 2-channel multiplexer/demultiplexer with a single switch-enable (IN) input.

SGM44600 can handle rail-to-rail analog signals and is available in Pb-free TQFN-16(3mm × 3mm) package.

### APPLICATIONS

- Communication Systems
- Cell Phones
- Portable Instrumentation
- Audio Signal Routing
- Audio and Video Switching
- PCMCIA Cards
- Computer Peripherals
- Modems
- PDA's

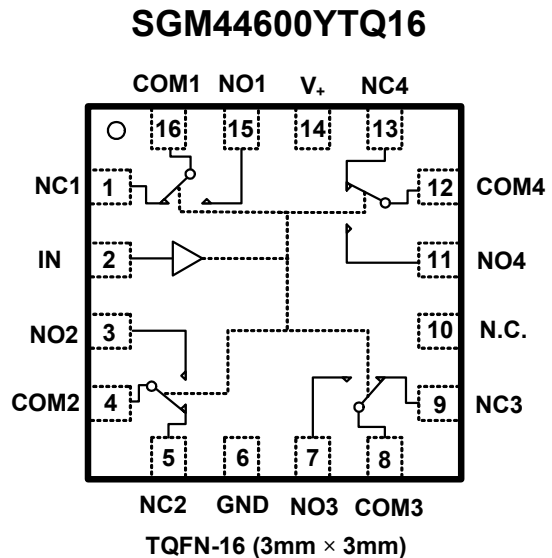
### FUNCTION TABLE

IN	Function	
	NC1, 2, 3 and 4	NO1, 2, 3 and 4
0	ON	OFF
1	OFF	ON

### FEATURES

- Low Voltage Operation: 1.8V to 5.5V
- Low On-Resistance: 4Ω (TYP)
- Low On-Resistance Flatness
- -3dB Bandwidth: 300MHz
- High Off-Isolation: -75dB at 1MHz
- Low Crosstalk: -100dB at 1MHz
- Rail-to-Rail Input and Output Operation
- Typical Power Consumption (<0.01μW)
- TTL/CMOS Compatible
- Lead (Pb) Free TQFN-16 (3mm × 3mm) Package
- Extended Industrial Temperature Range:  
-40°C to +85°C

### PIN CONFIGURATION (TOP VIEW)



**ORDERING INFORMATION**

MODEL	PIN-PACKAGE	SPECIFIED TEMPERATURE RANGE	ORDERING NUMBER	PACKAGE MARKING	PACKAGE OPTION
SGM44600	TQFN-16 (3mm x 3mm)	-40°C to +85°C	SGM44600YTQ16/TR	44600	Tape and Reel, 3000

**ABSOLUTE MAXIMUM RATINGS**

V <sub>+</sub> to GND.....	0V to 6V	Storage Temperature.....	-65°C to +150°C
Analog, Digital voltage range.....	-0.3V to (V <sub>+</sub> ) + 0.3V	Lead Temperature (soldering, 10s).....	260°C
Continuous Current NO, NC, or COM .....	±100mA	ESD Susceptibility	
Operating Temperature Range.....	-40°C to +85°C	HBM.....	2000V
Junction Temperature.....	150°C	MM.....	200V

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**CAUTION**

This integrated circuit can be damaged by ESD if you don't pay attention to ESD protection. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

**PIN DESCRIPTION**

NAME	TQFN PIN	FUNCTION
V <sub>+</sub>	14	Power supply
GND	6	Ground
IN	2	Digital control pin to connect the COM terminal to the NO or NC terminals
N.C.	10	Not internally connected.
COM <sub>x</sub>	16, 4, 8, 12	Common terminal
NO <sub>x</sub>	15, 3, 7, 11	Normally-open terminal
NC <sub>x</sub>	1, 5, 9, 13	Normally-closed terminal
Exposed Pad	GND	Exposed pad should be soldered to PCB board and connected to GND.

Note: NO<sub>x</sub>, NC<sub>x</sub> and COM<sub>x</sub> terminals may be an input or output.

**ELECTRICAL CHARACTERISTICS**

( $V_+$  = +4.5V to +5.5V, GND = 0V,  $V_{IH}$  = +1.6V,  $V_{IL}$  = +0.6V,  $T_A$  = -40°C to +85°C. Typical values are at  $V_+$  = +5.0V,  $T_A$  = +25°C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP	MAX	UNITS
<b>ANALOG SWITCH</b>							
Analog Signal Range	$V_{NO}, V_{NC}, V_{COM}$		-40°C to +85°C	0		$V_+$	V
On-Resistance	$R_{ON}$	$V_+$ = 4.5V, $V_{NO}$ or $V_{NC}$ = 1.2V, $I_{COM}$ = -100mA, Test Circuit 1	+25°C		4	6	Ω
			-40°C to +85°C			7	Ω
On-Resistance Match Between Channels	$\Delta R_{ON}$	$V_+$ = 4.5V, $V_{NO}$ or $V_{NC}$ = 1.2V, $I_{COM}$ = -100mA, Test Circuit 1	+25°C		0.4	2.5	Ω
			-40°C to +85°C			3	Ω
On-Resistance Flatness	$R_{FLAT(ON)}$	$V_+$ = 4.5V, $V_{NO}$ or $V_{NC}$ = 1.2V, 4.5V, $I_{COM}$ = -100mA, Test Circuit 1	+25°C		2	3	Ω
			-40°C to +85°C			3.5	Ω
Source OFF Leakage Current	$I_{NC(OFF)}, I_{NO(OFF)}$	$V_+$ = 5.5V, $V_{NO}$ or $V_{NC}$ = 3.3V/0.3V, $V_{COM}$ = 0.3V/3.3V	-40°C to +85°C			1	μA
Channel ON Leakage Current	$I_{NC(ON)}, I_{NO(ON)},$ $I_{COM(ON)}$	$V_+$ = 5.5V, $V_{COM}$ = 0.3V/3.3V, $V_{NO}$ or $V_{NC}$ = 0.3V/3.3V, or floating	-40°C to +85°C			1	μA
<b>DIGITAL INPUTS</b>							
Input High Voltage	$V_{INH}$		-40°C to +85°C	1.6			V
Input Low Voltage	$V_{INL}$		-40°C to +85°C			0.5	V
Input Leakage Current	$I_{IN}$	$V_+$ = 5.5V, $V_{IN}$ = 0V or 5.5V	-40°C to +85°C			1	μA
<b>DYNAMIC CHARACTERISTICS</b>							
Turn-On Time	$t_{ON}$	$V_{IH}$ = 3V, $V_{IL}$ = 0V, Test Circuit2	+25°C		29.5		ns
Turn-Off Time	$t_{OFF}$		+25°C		29.5		ns
Break-Before-Make Time Delay	$t_D$	$V_{IH}$ = 3V, $V_{IL}$ = 0V, Test Circuit4	+25°C		10.0		ns
Charge Injection	Q	$V_G$ = GND, $R_G$ = 0Ω, $V_{IH}$ = 3V, $V_{IL}$ = 0V, $C_L$ = 1.0nF, $Q$ = $C_L \times V_{OUT}$ , Test Circuit3	+25°C		4.8		pC
Off Isolation	$O_{ISO}$	$V_{BIAS}$ = 2.1V, Signal = 0dBm, $V_{IH}$ = 3V, $V_{IL}$ = 0V, Test Circuit5	1MHz	+25°C		-75	dB
			10MHz	+25°C		-55	
Channel-to-Channel Crosstalk	$X_{TALK}$	$V_{BIAS}$ = 2.1V, Signal = 0dBm, $V_{IH}$ = 3V, $V_{IL}$ = 0V, Test Circuit6	1MHz	+25°C		-100	dB
			10MHz	+25°C		-60	
-3dB Bandwidth	BW	$V_{BIAS}$ = 2.1V, Signal = 0dBm, $V_{IH}$ = 3V, $V_{IL}$ = 0V, Test Circuit7	+25°C		300		MHz
Channel ON Capacitance	$C_{NC(ON)},$ $C_{NO(ON)},$ $C_{COM(ON)}$		+25°C		43.0		pF
<b>POWER REQUIREMENTS</b>							
Power Supply Range	$V_+$		-40°C to +85°C	1.8		5.5	V
Power Supply Current	$I_+$	$V_+$ = 5.5V, $V_{IN}$ = 0V or $V_+$	-40°C to +85°C			1	μA

Specifications subject to changes without notice.

**ELECTRICAL CHARACTERISTICS**

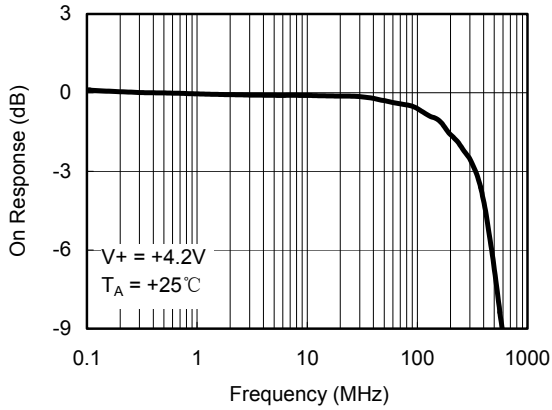
( $V_+ = +2.7V$  to  $+3.6V$ ,  $V_{IH} = +1.6V$ ,  $V_{IL} = +0.4V$ ,  $T_A = -40^\circ C$  to  $+85^\circ C$ . Typical values are at  $V_+ = +3.0V$ ,  $T_A = +25^\circ C$ , unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	TEMP	MIN	TYP	MAX	UNITS
<b>ANALOG SWITCH</b>							
Analog Signal Range	$V_{NO}, V_{NC}, V_{COM}$		$-40^\circ C$ to $+85^\circ C$	0		$V_+$	V
On-Resistance	$R_{ON}$	$V_+ = 2.7V$ , $V_{NO}$ or $V_{NC} = 1.2V$ , $I_{COM} = -10mA$ , Test Circuit 1	$+25^\circ C$		10	15	$\Omega$
			$-40^\circ C$ to $+85^\circ C$			18	$\Omega$
On-Resistance Match Between Channels	$\Delta R_{ON}$	$V_+ = 2.7V$ , $V_{NO}$ or $V_{NC} = 1.2V$ , $I_{COM} = -100mA$ , Test Circuit 1	$+25^\circ C$		1	3	$\Omega$
			$-40^\circ C$ to $+85^\circ C$			4	$\Omega$
On-Resistance Flatness	$R_{FLAT(ON)}$	$V_+ = 2.7V$ , $V_{NO}$ or $V_{NC} = 1.2V, 4.5V$ , $I_{COM} = -100mA$ , Test Circuit 1	$+25^\circ C$		6	9	$\Omega$
			$-40^\circ C$ to $+85^\circ C$			12	$\Omega$
Source OFF Leakage Current	$I_{NC(OFF)}, I_{NO(OFF)}$	$V_+ = 3.6V$ , $V_{NO}$ or $V_{NC} = 3.3V/0.3V$ , $V_{COM} = 0.3V/3.3V$	$-40^\circ C$ to $+85^\circ C$			1	$\mu A$
Channel ON Leakage Current	$I_{NC(ON)}, I_{NO(ON)},$ $I_{COM(ON)}$	$V_+ = 3.6V$ , $V_{COM} = 0.3V/3.3V$ , $V_{NO}$ or $V_{NC} = 0.3V/3.3V$ , or floating	$-40^\circ C$ to $+85^\circ C$			1	$\mu A$
<b>DIGITAL INPUTS</b>							
Input High Voltage	$V_{IH}$		$-40^\circ C$ to $+85^\circ C$	1.5			V
Input Low Voltage	$V_{IL}$		$-40^\circ C$ to $+85^\circ C$			0.4	V
Input Leakage Current	$I_{IN}$	$V_+ = 5.5V$ , $V_{IN} = 0V$ or $3.6V$	$-40^\circ C$ to $+85^\circ C$			1	$\mu A$
<b>DYNAMIC CHARACTERISTICS</b>							
Turn-On Time	$t_{ON}$	$V_{IH} = 1.5V$ , $V_{IL} = 0V$ , Test Circuit2	$+25^\circ C$		38.0		ns
Turn-Off Time	$t_{OFF}$		$+25^\circ C$		45.0		ns
Break-Before-Make Time Delay	$t_D$	$V_{IH} = 1.5V$ , $V_{IL} = 0V$ , Test Circuit4	$+25^\circ C$		5.6		ns
Charge Injection	Q	$V_G = GND$ , $R_G = 0\Omega$ , $V_{IH} = 1.5V$ , $V_{IL} = 0V$ , $C_L = 1.0nF$ , $Q = C_L \times V_{OUT}$ , Test Circuit3	$+25^\circ C$		2.6		pC
Off Isolation	$O_{ISO}$	$V_{BIAS} = 1.5V$ , Signal = 0dBm, $V_{IH} = 1.5V$ , $V_{IL} = 0V$ , Test Circuit5	1MH	$+25^\circ C$		-75	dB
			10MHZ	$+25^\circ C$		-55	dB
Channel-to-Channel Crosstalk	$X_{TALK}$	$V_{BIAS} = 1.5V$ , Signal = 0dBm, $V_{IH} = 1.5V$ , $V_{IL} = 0V$ , Test Circuit6	1MHZ	$+25^\circ C$		-100	dB
			10MHZ	$+25^\circ C$		-60	dB
-3dB Bandwidth	BW	$V_{BIAS} = 1.5V$ , Signal = 0dBm, $V_{IH} = 1.5V$ , $V_{IL} = 0V$ , Test Circuit7	$+25^\circ C$		300		MHz
Channel ON Capacitance	$C_{NC(ON)},$ $C_{NO(ON)},$ $C_{COM(ON)}$		$+25^\circ C$		43.0		pF

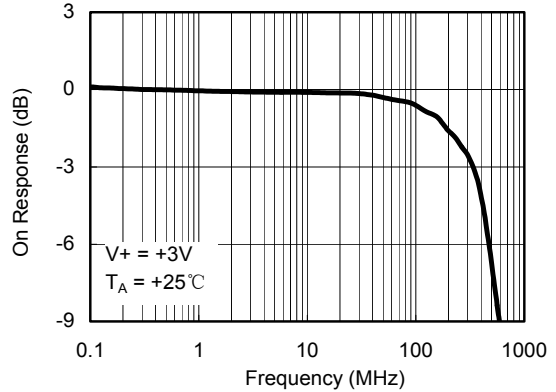
Specifications subject to changes without notice.

TYPICAL PERFORMANCE CHARACTERISTICS

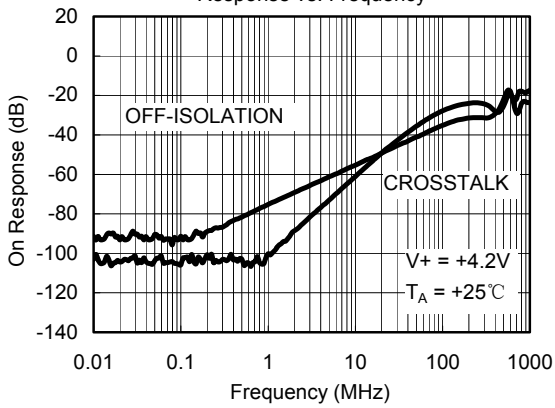
On Response vs. Frequency



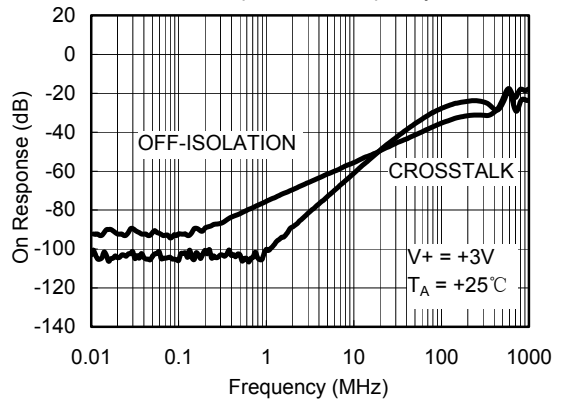
On Response vs. Frequency



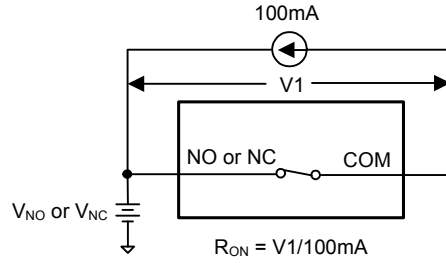
Response vs. Frequency



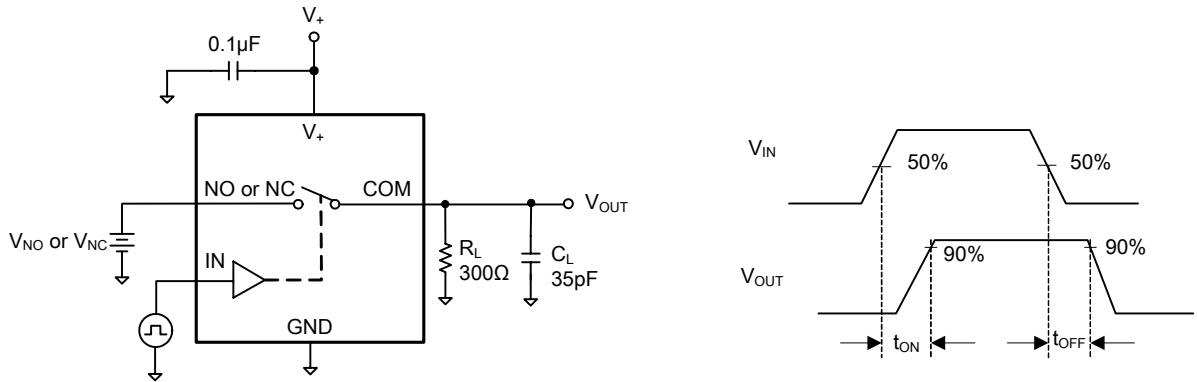
Response vs. Frequency



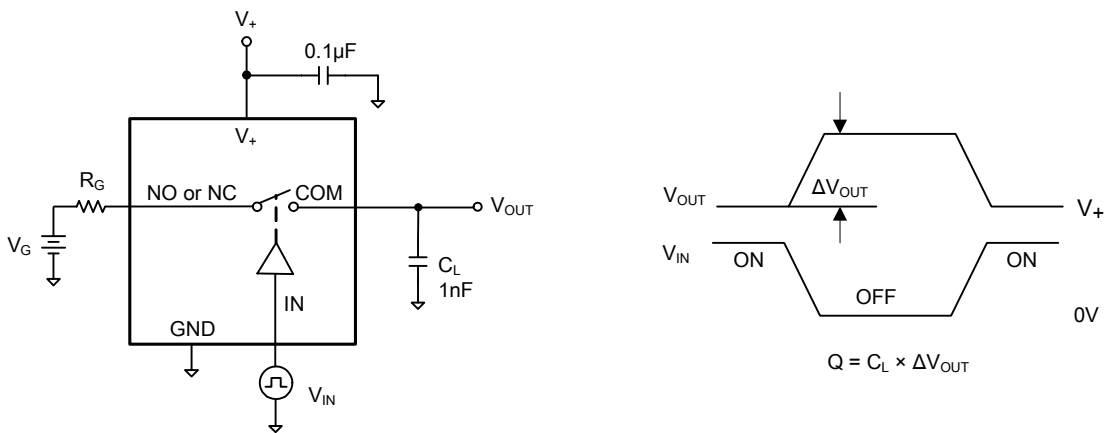
TEST CIRCUITS



Test Circuit 1. On Resistance

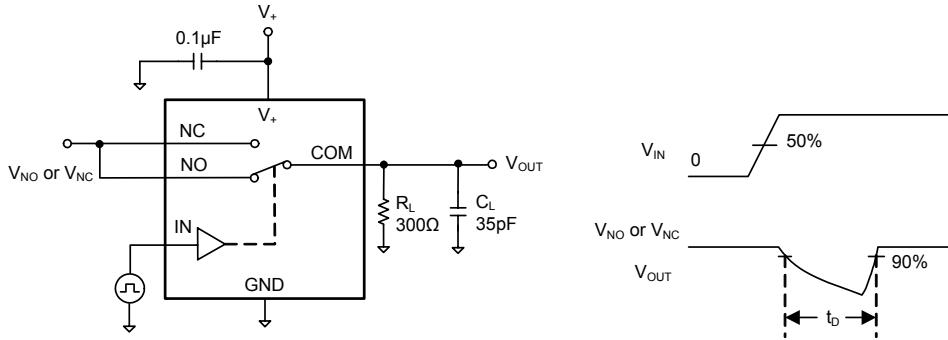


Test Circuit 2. Switching Times ( $t_{ON}$ ,  $t_{OFF}$ )

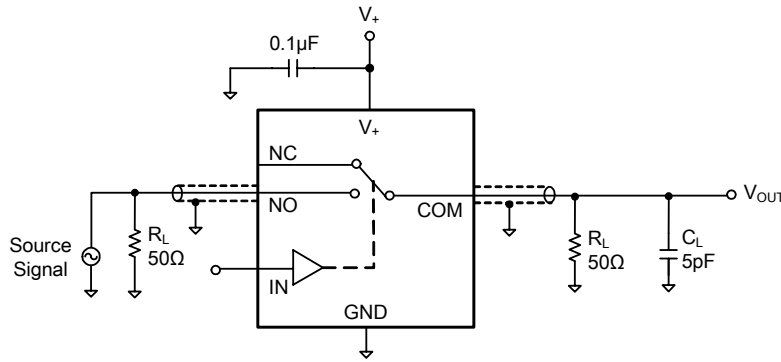


Test Circuit 3. Charge Injection

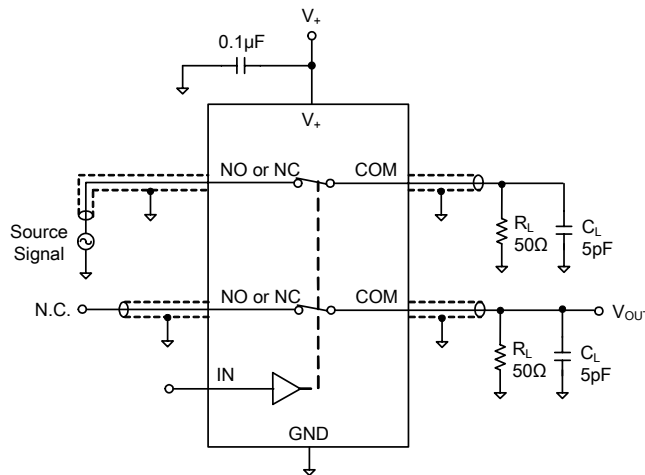
TEST CIRCUITS (Cont.)



Test Circuit 4. Break-Before-Make Time Delay ( $t_D$ )



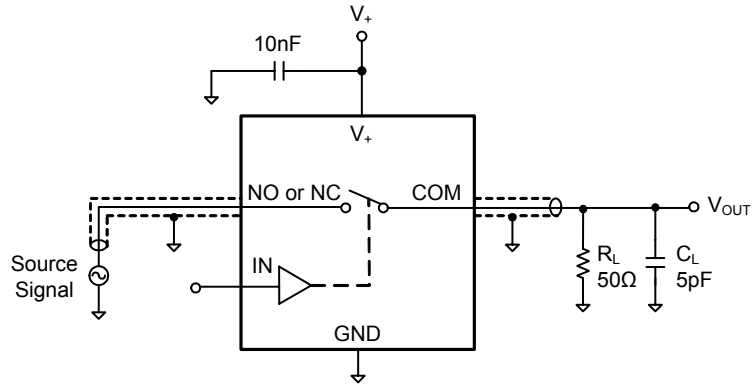
Test Circuit 5. Off Isolation



$$\text{Channel To Channel Crosstalk} = -20 \times \log \frac{V_{NO \text{ or } V_{NC}}}{V_{OUT}}$$

Test Circuit 6. Channel-to-Channel Crosstalk

TEST CIRCUITS (Cont.)

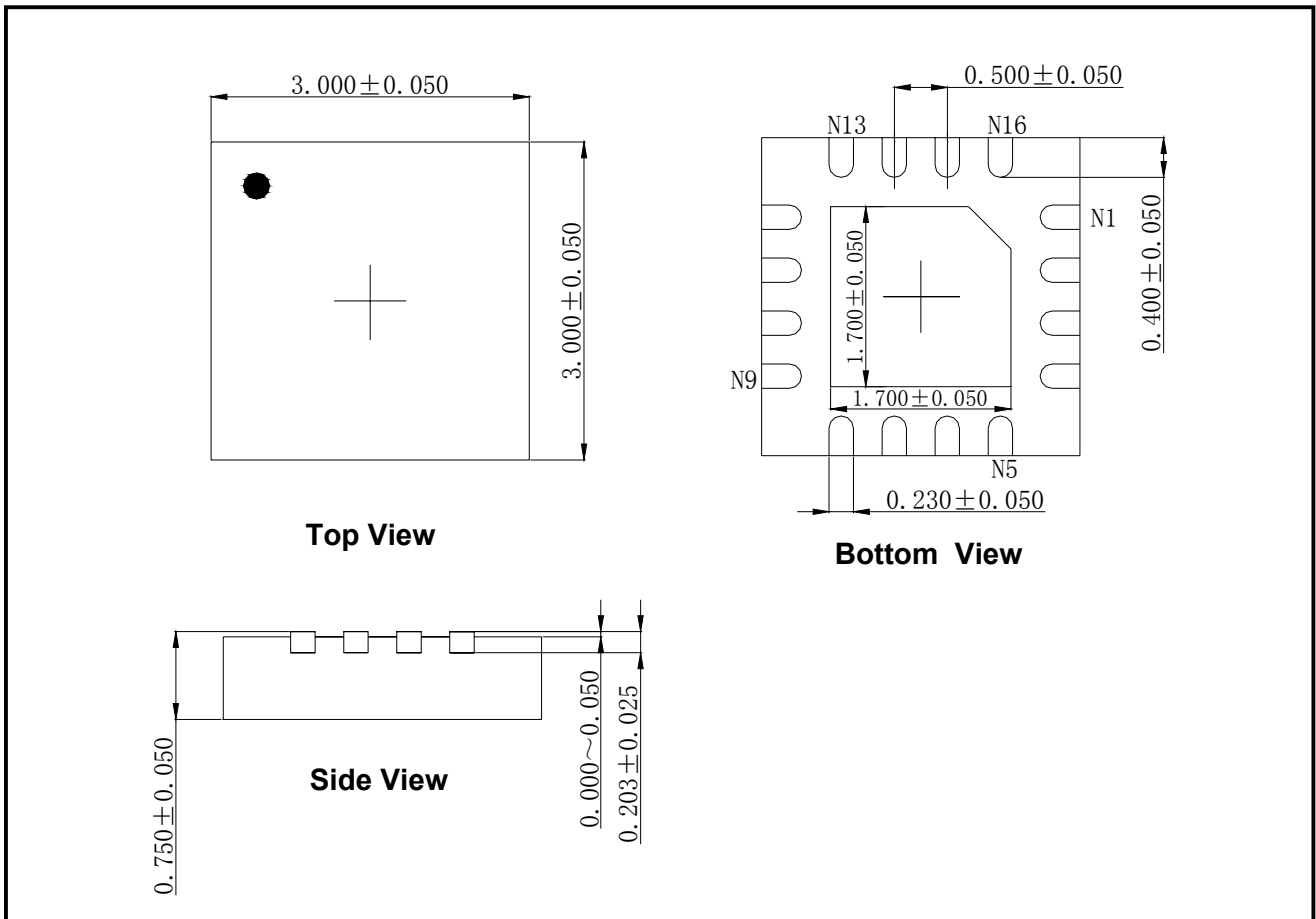


Test Circuit 7. -3dB Bandwidth



PACKAGE OUTLINE DIMENSIONS

TQFN-16 (3mm × 3mm)



Note: All linear dimensions are in millimeters.

05/2009 REV. A. 3

SGMICRO is dedicated to provide high quality and high performance analog IC products to customers. All SGMICRO products meet the highest industry standards with strict and comprehensive test and quality control systems to achieve world-class consistency and reliability.

For information regarding SGMICRO Corporation and its products, see [www.sg-micro.com](http://www.sg-micro.com)